

**PRODUCT SPECIFICATION**

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Approved by:

Reviewed by:

Produced by:

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1. Scope :

This product specification contains the test results that general performances of A1256 SERIES connector were examined.

2. Part name & part number :

| Part name | Part number |
|-----------|----------------------|
| Housing | A1256H |
| Terminal | A1256-T |
| Wafer | A1256WR-S,A1256WRA-S |

3. Construction 、 dimensions 、 material & surface finish :

Construction and dimensions shall be in accordance with the referenced drawings.

Material and surface finish shall be as specified below.

| Part name | | Material | Surface finish |
|----------------|------|-----------------|----------------|
| Housing | | Nylon 66 | UL 94V-0 |
| Terminal | | Phosphor Bronze | Gold-plated |
| | Post | Brass | Tin-plated |
| Wafer (SMT) | Body | Nylon6T/LCP | UL 94V-0 |
| | Tab | Brass | Tin-plated |

4. Characteristics :

Current rating : 1A AC,DC

Voltage rating : 200V AC,DC

Temperature range : -40°C ~105°C

5. Conditions :

The conditions shall be in accordance with the referenced drawing of next page.

| Number | Item | Requirement |
|--------|----------------------|---|
| (1) | Bend up | 4° max. |
| | Bend down | 4° max. |
| | Twisting | 3° max. |
| | Rolling | 8° max. |
| (2) | Bell mouth (flare) | 0.2-0.5 mm |
| (3) | Cut-off tab length | 0.2 mm max. |
| (4) | Extruded wire length | 0-0.5 mm |
| (5) | Seam | Seam shall not be opened and no wire allowed out of crimping area |
| | Wire strip length | 1.2-1.7 mm ref. |
| (8) | Lance height | 0.3 mm ref. |

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6. Mechanical test :

6.1 Crimp width 、crimp height & crimp strength

After crimping , the crimped areas [(6) 、(7)] should be as follows.

| Wire Size (AWG) | Terminal Part Number | Conductor(mm) | | Insulation(mm) | | Crimp Strength (Kg) |
|-----------------|----------------------|---------------|--------------|----------------|--------------|---------------------|
| | | Crimp Width | Crimp Height | Crimp Width | Crimp Height | |
| # 28 | A1256-T | 0.8±0.15 | 0.59~0.68 | 0.95 (max) | 0.80(max) | 1.0(min) |
| # 30 | | | 0.55~0.64 | | 0.70(max) | 0.5(min) |
| # 32 | | | 0.51~0.60 | | 0.60(max) | 0.4(min) |

Note : no distorted after terminal crimped.

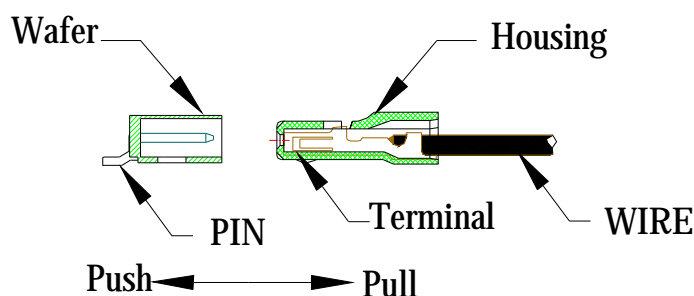
6.2 Insertion force (I.F.) & withdrawal force (W.F.)

(1) Requirement : (Single Row)

| Number of Circuits | At initial | | At 50th |
|--------------------|------------|------------|------------|
| | I.F. (max) | W.F. (min) | W.F. (min) |
| Single | 0.80Kg | 0.05Kg | 0.04Kg |
| 2P | 1.00Kg | 0.08Kg | 0.06Kg |
| 20P | 6.00Kg | 0.80Kg | 0.70Kg |
| 30P | 8.00Kg | 1.20Kg | 1.10Kg |

(2) Test method : Housing with crimped terminal and wafer shall be mated and unmated on the same axis. Initial insertion and withdrawal forces and withdrawal forces at 30th shall be measured for single circuit and multi-circuits. For the measurement of single circuit , housing lock shall be removed.

Insertion and withdrawal speed : 20±5 mm/minute.



(3) Test results : (Single Row)

| Number of Circuits | | At initial | | AT 50th |
|--------------------|------|------------|-----------|-----------|
| | | I.F. (Kg) | W.F. (Kg) | W.F. (Kg) |
| Single | Max. | 0.42 | 0.28 | 0.24 |
| | Min. | 0.29 | 0.20 | 0.16 |
| | Ave. | 0.33 | 0.23 | 0.20 |

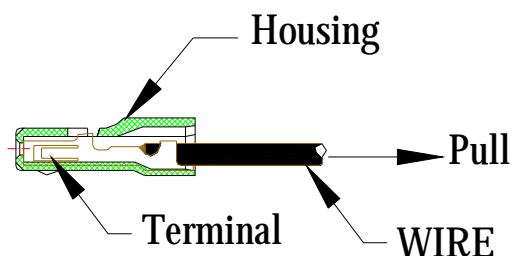
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| | | | | |
|-----|------|------|------|------|
| 2P | Max. | 0.69 | 0.42 | 0.36 |
| | Min. | 0.46 | 0.34 | 0.27 |
| | Ave. | 0.58 | 0.38 | 0.31 |
| 20P | Max. | 3.38 | 1.62 | 1.51 |
| | Min. | 1.89 | 1.19 | 1.02 |
| | Ave. | 2.86 | 1.50 | 1.42 |
| 30P | Max. | 4.25 | 2.86 | 2.68 |
| | Min. | 2.52 | 2.02 | 1.89 |
| | Ave. | 3.58 | 2.62 | 2.51 |

6.2 Post retention force

(1) Requirement : 0.5 Kg (min.)

(2) Test method : Crimped terminal shall be mounted in a housing and pulled in an alignment. The load to pull the terminal out of the housing shall be measured.



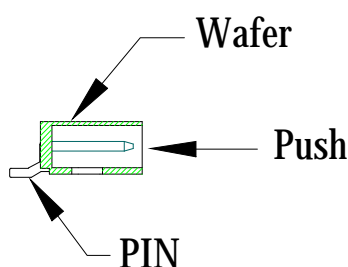
(3) Test results :

| Max. | Min. | Ave. | N=10 |
|--------|---------|---------|------|
| 1.62Kg | 1.02 Kg | 1.27 Kg | |

6.4 Post retention force

(1) Requirement : 0.5Kg (min.)

(2) Test method : The end of a post shall be pushed in a perpendicular to wafer. The load to make the post start moving shall be measured.



(3) Test results :

| Max. | Min. | Ave. | N=10 |
|---------|---------|---------|------|
| 1.49 Kg | 1.01 Kg | 1.27 Kg | |

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7. Electrical test :
7.1 Contact resistance

- (1) Requirement : Initial : 40 mΩ (max.)
After environmental test : 50 mΩ (max.)
- (2) Condition : Test current : 10 mA (DC)
Open voltage : 20mV (max.)
- (3) Test result : See items 8.1 ~ 8.4

7.2 Insulation resistance

- (1) Requirement : Initial : 100 MΩ (min.)
After humidity test : 50 MΩ (min.)
After thermal shock test : 50 MΩ (min.)
- (2) Test method : DC 500V shall be applied between outer surface of housing and terminal and between adjacent terminals to measure insulation resistance.
(MIL-STD-202 , test method 302 , condition B)
- (3) Test result : See items 8.1 & 8.3

7.3 Dielectric withstanding voltage

- (1) Requirement : There shall be no breakdown nor flashover.
- (2) Test method : Initially AC 500V (rms) and after humidity and thermal shock tests AC 250V (rms) shall be applied between outer surface of housing and terminal and between adjacent terminals for one minutes. (MIL-STD-202 , test method 301)
Test current : 1mA
- (3) Test result : See items 8.1 & 8.3

8. Environment test :
8.1 Humidity

- (1) Requirement : Contact resistance shall be 50 milliohms (max.) after the test. Insulation resistance shall be 250 megohms (min.) after the test. There shall be no breakdown nor flashover on dielectric withstanding voltage test.
- (2) Test method : Mated connector shall be placed in a humidity chamber of the following conditions. After the test , contact resistance , insulation resistance and dielectric withstanding voltage shall be measured. (MIL-STD-202 , test method 103 , condition A)
Temperature : 40±2 °C
Humidity : 90% ~ 95% (RH)
Period : 240 hours continuously

(3) Test results :

| Test item | Initial (mΩ) | | | After test (mΩ) | | |
|--------------------|--------------|------|------|-----------------|-----|-----|
| Contact resistance | Max. | Min. | Ave. | Max. | Min | Ave |
| | 8.7 | 5.6 | 6.9 | 9.8 | 6.8 | 7.9 |

N=30

| Test item | Housing-Terminal (MΩ) | | Terminal-Terminal (MΩ) | |
|-----------------------|-----------------------|------------|------------------------|------------|
| Insulation resistance | Initial | After test | Initial | After test |
| | 500 min. | 250 min. | 500 min. | 250 min. |

N=20

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| Test item | Housing-Terminal (MΩ) | | Terminal-Terminal (MΩ) | |
|-----------|-----------------------|------------|------------------------|------------|
| D.W.V. | Initial | After test | Initial | After test |
| | Good | Good | Good | Good |

(D.W.V. : Dielectric withstanding voltage)

N=20

8.2 Salt spray

- (1) Requirement : Contact resistance shall be 50 milliohms (max.) after the test.
- (2) Test method : Mated connector shall be subjected to salt spray test of the following conditions. After the test, specimen shall be washed with running water and dried naturally before the measurement of contact resistance.

Temperature : 40±2 °

Salt Solution Concentration : 5%

Humidity : 90% ~ 95% (RH)

Period :8 or 16 or 24 or 32 or 48 hours

- (3) Test result :

| Test item | Initial (mΩ) | | | After test (mΩ) | | |
|--------------------|--------------|------|------|-----------------|------|------|
| Contact resistance | Max. | Min. | Ave. | Max. | Min. | Ave. |
| | 8.8 | 5.7 | 7.3 | 9.2 | 6.3 | 7.8 |

N=30

8.3 Thermal shock

- (1) Requirement : Contact resistance shall be 50 milliohms (max.) after the test. Insulation resistance shall be 250 megohms (min.) after the test. There shall be no breakdown nor flashover on dielectric withstanding voltage test.

- (2) Test method : Mated connector shall be subjected to thermal shock test of the following conditions. After the test , contact resistance , insulation resistance and dielectric withstanding voltage shall be measured.

1 cycle consists of :

-55 °C for 30 minutes

+85 °C for 30 minutes

Times of cycles : 25 cycles

- (3) Test results :

| Test item | Initial (mΩ) | | | After test (mΩ) | | |
|--------------------|--------------|------|------|-----------------|------|------|
| Contact resistance | Max. | Min. | Ave. | Max. | Min. | Ave. |
| | 8.9 | 5.8 | 7.1 | 9.7 | 6.4 | 8.3 |

N=20

| Test item | Housing-Terminal (MΩ) | | Terminal-Terminal (MΩ) | |
|-----------------------|-----------------------|------------|------------------------|------------|
| Insulation resistance | Initial | After test | Initial | After test |
| | 500 min. | 250 min. | 500 min. | 250 min. |

| Test item | Housing-Terminal (MΩ) | | Terminal-Terminal (MΩ) | |
|-----------|-----------------------|------------|------------------------|------------|
| D.W.V. | Initial | After test | Initial | After test |
| | Good | Good | Good | Good |

N=20

D.W.V. : Dielectric withstanding voltage

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(2) Test method : Mated connector shall be mounted on a PCB and subjected to a vibration test of the following conditions. During the test , current continuity shall

be checked. After the test , contact resistance shall be measured.

(MIL-STD-202 , test method 201)

Frequency : 10~55~10 Hz/min.

Amplitude : 1.5 mm

Direction : 1. Axis of up and down

2. Axis of right and left

3. Axis of front and back

(3) Test result :

| Test item | Initial (mΩ) | | | After test (mΩ) | | |
|--------------------|--------------|------|------|-----------------|-----|------|
| Contact resistance | Max. | Min. | Ave. | Max. | Min | Ave. |
| | 8.7 | 6.8 | 7.5 | 9.3 | 6.9 | 7.8 |

N=30

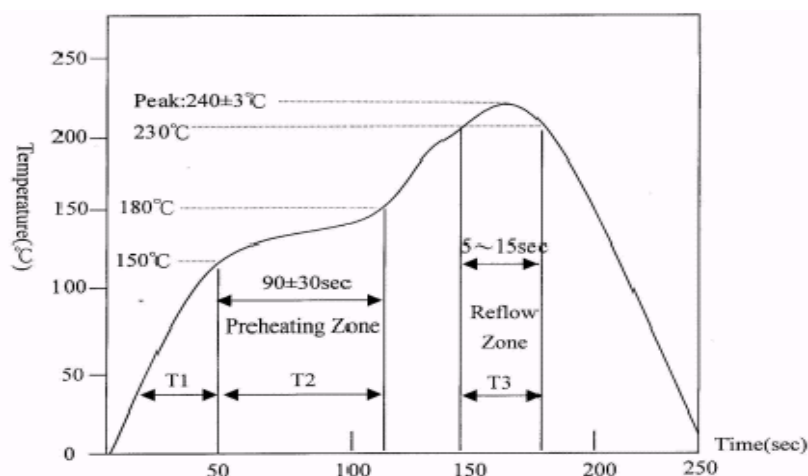
Current discontinuity : There shall be no current discontinuity longer than 1 microsecond during the test.

8.5 Solderability

(1) Requirements : Solder-dipping section shall be covered by solder entirely.

(2) Test method : Fluxed soldering section of shrouded header shall be dipped in solder of the following conditions.

INFRARED REFLOW CONDITION



RAMP UP
2°C~3°C/Sec

Preheat
150°C~180°C

RAMP
UP

ramp down
4°C~7°C/Sec

90Sec ± 30Sec 30sec.

| | | |
|-----|--------------------------------|--------------|
| T1: | temperature ramp up rate: | 2°C~3°C/ sec |
| T2: | preheat: 150°C ~ 160°C | 60~120sec |
| T3: | time Over 230°C: | 5~15sec |
| | ramp down rate during cooling: | 4°C~7°C/sec |
| | peak temperature : | 240°C Max |

(3) Test result : Good.

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8.6 Resistance to soldering heat

- (1) Requirements : There shall be no deformation nor damage which may affect the performance.
- (2) Test method : Specimen shall be mounted on a PCB (inserted only) and subjected to resistance to soldering heat test of the following conditions.
 - Solder temperature : 250 ± 5 °C
 - Immersion period : 3-5 seconds
- (3) Test result : Good.